# NX3P1107

# Logic controlled high-side power switch

Rev. 1 — 9 January 2013

**Product data sheet** 

### 1. General description

The NX3P1107 is a high-side load switch which features a low ON resistance P-channel MOSFET that supports more than 1.5 A of continuous current. Designed for operation from 0.9 V to 3.6 V, it is used in power domain isolation applications to reduce power dissipation and extend battery life. The enable logic includes integrated logic level translation making the device compatible with lower voltage processors and controllers. The NX3P1107 is ideal for portable, battery operated applications due to low ground current and ultra-low OFF-state current.

### 2. Features and benefits

- Wide supply voltage range from 0.9 V to 3.6 V
- Very low ON resistance:
  - 34 mΩ at a supply voltage of 3.3 V
- High noise immunity
- Low OFF-state leakage current (2.0 μA maximum)
- 1.2 V control logic at a supply voltage of 3.6 V
- High current handling capability (1.5 A continuous current)
- Turn-on slew rate limiting
- ESD protection:
  - HBM JESD22-A114F Class 3A exceeds 4000 V
  - CDM AEC-Q100-011 revision B exceeds 500 V
- Specified from -40 °C to +85 °C

# 3. Applications

- Cell phone
- Digital cameras and audio devices
- Portable and battery-powered equipment



### Logic controlled high-side power switch

# 4. Ordering information

#### Table 1. Ordering information

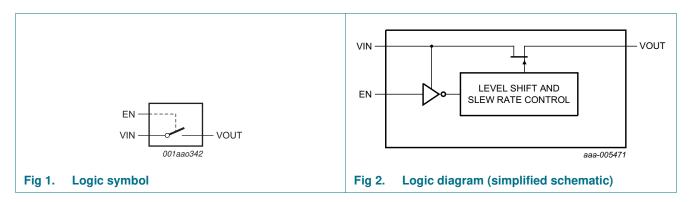
Type number	Package	ackage						
	Temperature range	Name	Description	Version				
NX3P1107UK	-40 °C to +85 °C	WLCSP4	wafer level chip-size package; 4 bumps; 0.96 $\times$ 0.96 $\times$ 0.55 mm. (Backside coating included)	NX3P1107/NX3P1108				

## 5. Marking

#### Table 2. Marking codes

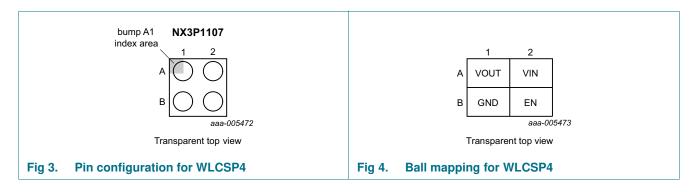
Type number	Marking code
NX3P1107UK	x7

## 6. Functional diagram



# 7. Pinning information

### 7.1 Pinning



#### Logic controlled high-side power switch

### 7.2 Pin description

Table 3. Pin description

Symbol	Pin	Description
VOUT	A1	output voltage
GND	B1	ground (0 V)
VIN	A2	input voltage
EN	B2	enable input (active HIGH)

## 8. Functional description

Table 4. Function table[1]

Input EN	Switch
L	switch OFF
Н	switch ON

<sup>[1]</sup> H = HIGH voltage level; L = LOW voltage level.

## 9. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{I}$	input voltage	input EN	<u>[1]</u> –0.5	+4.0	V
		input VIN	[2] -0.5	+4.0	V
$V_{SW}$	switch voltage	output VOUT	[2] -0.5	$V_{I(VIN)}$	V
I <sub>IK</sub>	input clamping current	input EN: $V_{I(EN)} < -0.5 \text{ V}$	-50	-	mA
I <sub>SK</sub>	switch clamping current	input VIN: $V_{I(VIN)} < -0.5 \text{ V}$	-50	-	mA
		output VOUT: $V_{O(VOUT)} < -0.5 \text{ V}$	-50	-	mA
		output VOUT: $V_{O(VOUT)} > V_{I(VIN)} + 0.5 V$	-	50	mA
I <sub>SW</sub>	switch current	$V_{SW} > -0.5 \text{ V}$	-	±1500	mA
T <sub>j(max)</sub>	maximum junction temperature		-40	+125	°C
T <sub>stg</sub>	storage temperature		<b>–65</b>	+150	°C
P <sub>tot</sub>	total power dissipation		<u>[3]</u> _	300	mW

<sup>[1]</sup> The minimum input voltage rating may be exceeded if the input current rating is observed.

<sup>[2]</sup> The minimum and maximum switch voltage ratings may be exceeded if the switch clamping current rating is observed.

<sup>[3]</sup> The (absolute) maximum power dissipation depends on the junction temperature  $T_j$ . Higher power dissipation is allowed in conjunction with lower ambient temperatures. The conditions to determine the specified values are  $T_{amb} = 85$  °C and the use of a two layer PCB.

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## 10. Recommended operating conditions

#### Table 6. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{I}$	input voltage		0.9	3.6	V
T <sub>amb</sub>	ambient temperature		-40	+85	°C

### 11. Thermal characteristics

#### Table 7. Thermal characteristics

Symbol	Parameter	Conditions	Тур	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient		[1][2] 84	K/W

<sup>[1]</sup> The overall R<sub>th(j-a)</sub> can vary depending on the board layout. To minimize the effective R<sub>th(j-a)</sub>, all pins must have a solid connection to larger Cu layer areas for example, to the power and ground layer. In multi-layer PCB applications, use the second layer to create a large heat spreader area right below the device. If this layer is either ground or power, connect it with several vias to the top layer connected to the device ground or supply. Try not to use any solder-stop varnish under the chip.

### 12. Static characteristics

Table 8. Static characteristics

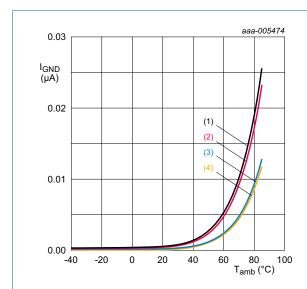
 $V_{I(VIN)} = 0.9 \text{ V to } 3.6 \text{ V, unless otherwise specified; Voltages are referenced to GND (ground = 0 V).}$ 

Symbol Parameter		Conditions	T <sub>amb</sub> = 25 °C		$T_{amb} = -40  ^{\circ}\text{C} \text{ to } +85  ^{\circ}\text{C}$		Unit	
			Min	Тур	Max	Min	Max	
$V_{IH}$	HIGH-level	EN input		,			•	
input voltage	input voltage	$V_{I(VIN)} = 0.9 \text{ V to } 1.1 \text{ V}$	-	-	-	0.8	-	V
		V <sub>I(VIN)</sub> = 1.1 V to 1.3 V	-	-	-	1.0	-	V
		$V_{I(VIN)} = 1.3 \text{ V to } 1.8 \text{ V}$	-	-	-	1.1	-	V
		$V_{I(VIN)} = 1.8 \text{ V to } 3.6 \text{ V}$	-	-	-	1.1	-	V
V <sub>IL</sub>	LOW-level input voltage	EN input						
		$V_{I(VIN)} = 0.9 \text{ V to } 1.1 \text{ V}$	-	-	-	-	0.2	V
		$V_{I(VIN)} = 1.1 \text{ V to } 1.3 \text{ V}$	-	-	-	-	0.3	V
		$V_{I(VIN)} = 1.3 \text{ V to } 1.8 \text{ V}$	-	-	-	-	0.4	V
		$V_{I(VIN)} = 1.8 \text{ V to } 3.6 \text{ V}$	-	-	-	-	0.45	V
II	input leakage current	$V_{I(EN)} = 0 \text{ V or } 3.6 \text{ V}$	-	0.1	-	-	1	μΑ
I <sub>GND</sub>	ground current	$V_{I(EN)} = 0 \text{ V or } 3.6 \text{ V; VOUT open;}$ see Figure 5 and Figure 6	-	-	-	-2	-	μΑ
I <sub>S(OFF)</sub>	OFF-state leakage current	$\begin{split} &V_{I(VIN)} = 3.6 \text{ V; } V_{I(EN)} = GND; \\ &V_{I(VOUT)} = GND \text{ or } 3.6 \text{ V; see } \frac{Figure \ 10}{\text{and } \frac{Figure \ 11}{\text{odd}}} \end{split}$	-	0.1	-	-	2.0	μА

<sup>[2]</sup> Rely on the measurement data given for a rough estimation of the R<sub>th(j-a)</sub> in your application. The actual R<sub>th(j-a)</sub> value may vary in applications using different layer stacks and layouts

### Logic controlled high-side power switch

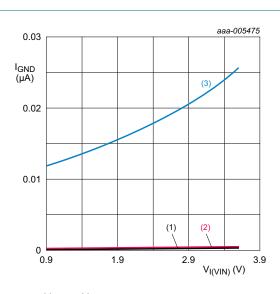
### 12.1 Graphs



 $V_{I(EN)} = V_{I(VIN)}$ .

- (1)  $V_{I(VIN)} = 3.6 \text{ V}.$
- (2)  $V_{I(VIN)} = 3.3 \text{ V}.$
- (3)  $V_{I(VIN)} = 1.2 \text{ V}.$
- (4)  $V_{I(VIN)} = 0.9 V$ .

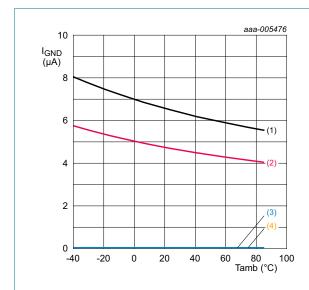
Fig 5. Waveform showing the ground current versus temperature



 $V_{I(EN)} = V_{I(VIN)}$ .

- (1)  $T_{amb} = -40 \, ^{\circ}C$ .
- (2)  $T_{amb} = 25 \, ^{\circ}C$ .
- (3)  $T_{amb} = 85 \, ^{\circ}C$ .

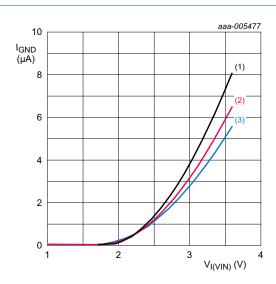
Fig 6. Waveform showing the ground current versus input voltage on pin VIN



 $V_{I(EN)} = 1.2 V$ 

- (1)  $V_{I(VIN)} = 3.6 \text{ V}.$
- (2)  $V_{I(VIN)} = 3.3 \text{ V}.$
- (3)  $V_{I(VIN)} = 1.2 \text{ V}.$
- (4)  $V_{I(VIN)} = 0.9 \text{ V}.$

Fig 7. Waveform showing the ground current versus temperature



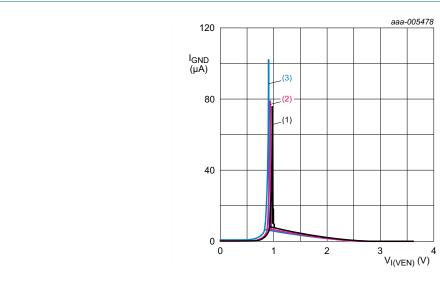
 $V_{I(EN)} = 1.2 \text{ V}$ 

- (1)  $T_{amb} = -40 \, ^{\circ}C$ .
- (2)  $T_{amb} = 85 \, ^{\circ}C$ .
- (3)  $T_{amb} = 25 \, ^{\circ}C$ .

Fig 8. Waveform showing the ground current versus input voltage on pin VIN

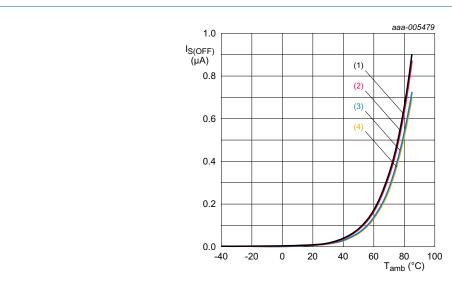
NX3P1107

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- (1)  $T_{amb} = -40 \, ^{\circ}C$ .
- (2)  $T_{amb} = 85 \, ^{\circ}C$ .
- (3)  $T_{amb} = 25 \, ^{\circ}C$ .

Fig 9. Waveform showing the ground current versus input voltage on pin EN

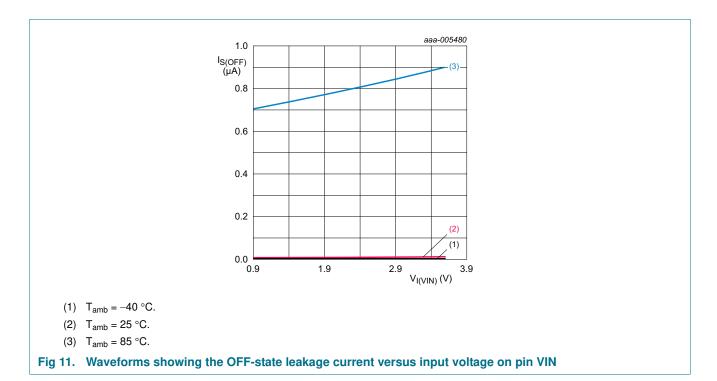


 $V_{I(EN)} = GND.$ 

- (1)  $V_{I(VIN)} = 3.6 \text{ V}.$
- (2)  $V_{I(VIN)} = 3.3 \text{ V}.$
- (3)  $V_{I(VIN)} = 1.2 \text{ V}.$
- (4)  $V_{I(VIN)} = 0.9 \text{ V}.$

Fig 10. Waveforms showing the OFF-state leakage current versus temperature

### Logic controlled high-side power switch



#### 12.2 ON resistance

Table 9. ON resistance

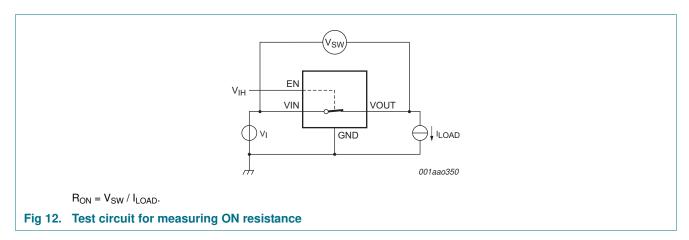
At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

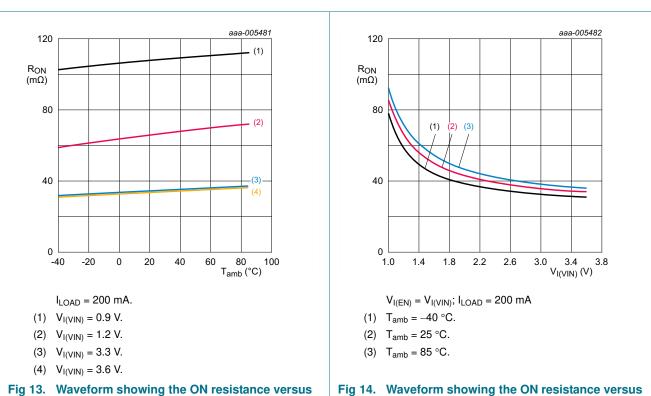
Symbol	Parameter	Conditions	T <sub>amb</sub> :	$T_{amb} = -40 \text{ °C to } +85 \text{ °C}$			
			Min	Typ[1]	Max		
R <sub>ON</sub>	ON resistance	$V_{I(EN)} = V_{I(VIN)}$ ; $I_{LOAD} = 200 \text{ mA}$ ; see <u>Figure 12</u> , <u>Figure 13</u> and <u>Figure 14</u>					
		$V_{I(VIN)} = 0.9 V$	-	105	140	mΩ	
		V <sub>I(VIN)</sub> = 1.2 V	-	68	81	mΩ	
		$V_{I(VIN)} = 1.5 V$	-	55	65	mΩ	
		V <sub>I(VIN)</sub> = 1.8 V	-	50	55	mΩ	
		$V_{I(VIN)} = 2.5 V$	-	40	44	mΩ	
		$V_{I(VIN)} = 3.3 V$	-	34	40	mΩ	

<sup>[1]</sup> Typical values are measured at  $T_{amb}$  = 25 °C.

### Logic controlled high-side power switch

### 12.3 ON resistance test circuit and waveforms





NX3P1107

input voltage

temperature

### Logic controlled high-side power switch

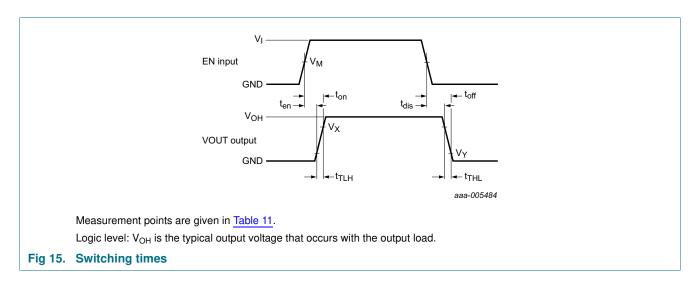
# 13. Dynamic characteristics

Table 10. Dynamic characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); for test circuit see Figure 16.

Symbol	Parameter	Conditions	1	T <sub>amb</sub> = 25 °C		
			Min	Тур	Max	
t <sub>en</sub>	enable time	EN to VOUT; see Figure 15				
		$V_{I(VIN)} = 1.8 \text{ V}$	-	120	-	μS
		$V_{I(VIN)} = 3.3 \text{ V}$	-	70	-	μS
t <sub>dis</sub>	disable time	EN to VOUT; see Figure 15				
		$V_{I(VIN)} = 1.8 \text{ V}$	-	5.6	-	μS
		$V_{I(VIN)} = 3.3 \text{ V}$	-	5.8	-	μS
t <sub>on</sub>	turn-on time	EN to VOUT; see Figure 15				
		$V_{I(VIN)} = 1.8 \text{ V}$	-	220	-	μS
		$V_{I(VIN)} = 3.3 \text{ V}$	-	150	-	μS
t <sub>off</sub>	turn-off time	EN to VOUT; see Figure 15				
		$V_{I(VIN)} = 1.8 \text{ V}$	-	118	-	μS
		$V_{I(VIN)} = 3.3 \text{ V}$	-	118	-	μS
t <sub>TLH</sub>	LOW to HIGH output	VOUT; see Figure 15				
	transition time	$V_{I(VIN)} = 1.8 \text{ V}$	-	100	-	μS
		$V_{I(VIN)} = 3.3 \text{ V}$	-	80	-	μS
t <sub>THL</sub>	HIGH to LOW output	VOUT; see Figure 15				
	transition time	$V_{I(VIN)} = 1.8 \text{ V}$	-	112.5	-	μS
		$V_{I(VIN)} = 3.3 \text{ V}$	-	112.5	-	μS

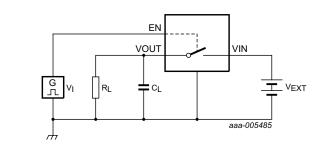
#### 13.1 Waveform and test circuits



### Logic controlled high-side power switch

Table 11. Measurement points

Supply voltage	EN Input	Output			
V <sub>I(VIN)</sub>	V <sub>M</sub>	V <sub>X</sub>	V <sub>Y</sub>		
0.9 V to 3.6 V	$0.5 \times V_I$	$0.9 \times V_{OH}$	$0.1 \times V_{OH}$		



Test data is given in Table 12.

Definitions test circuit:

R<sub>L</sub> = Load resistance.

 $C_L$  = Load capacitance including jig and probe capacitance.

V<sub>EXT</sub> = External voltage for measuring switching times.

Fig 16. Test circuit for measuring switching times

#### Table 12. Test data

Supply voltage	EN Input	Load	Load		
V <sub>EXT</sub>	V <sub>I</sub>	CL	R <sub>L</sub>		
0.9 V to 3.6 V	3.3 V	0.1 μF	500 Ω		

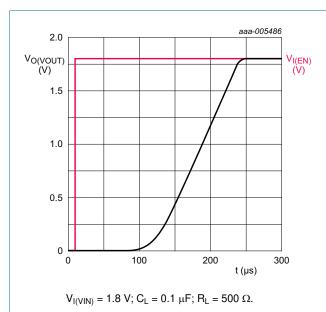


Fig 17. Waveform showing the enable time

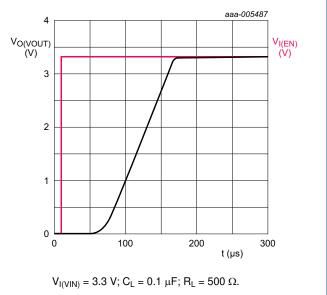
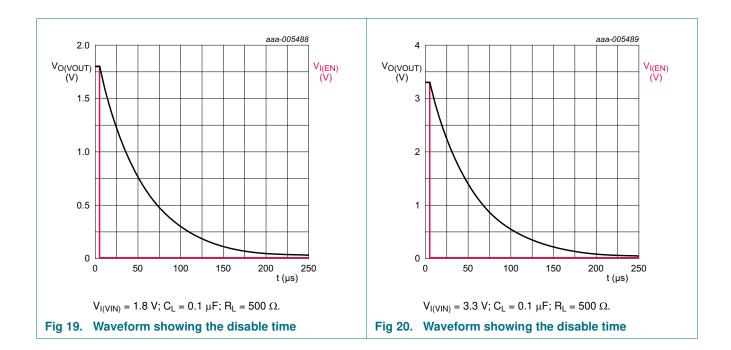


Fig 18. Waveform showing the enable time

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Logic controlled high-side power switch

# 14. Package outline

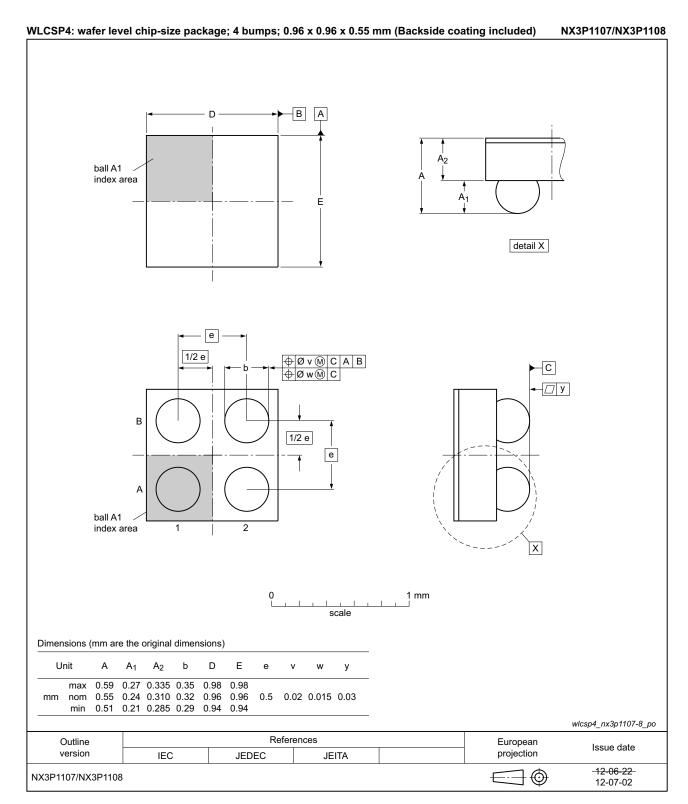


Fig 21. Package outline WLCSP4 (NX3P1107/NX3P1108)

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### Logic controlled high-side power switch

## 15. Abbreviations

#### Table 13. Abbreviations

Acronym	Description
CDM	Charged Device Model
ESD	ElectroStatic Discharge
HBM	Human Body Model
MOSFET	Metal-Oxide Semiconductor Field Effect Transistor

# 16. Revision history

### Table 14. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
NX3P1107 v.1	20130109	Product data sheet	-	-

#### Logic controlled high-side power switch

### 17. Legal information

#### 17.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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Product [short] data sheet	Production	This document contains the product specification.

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### Logic controlled high-side power switch

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## Logic controlled high-side power switch

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